



### Features

- Frequency: 8-12GHz
- Small Signal Gain: 22dB
- Gain Flatness:  $\pm 0.6$ dB
- P-1dB: 33.5dBm
- Psat: 34dBm
- Power Supply: +8V@550mA
- Input/Output: 50 $\Omega$
- Die Size: 2.7 x 2.0 x 0.1 mm

### Typical Applications

- Test Instrumentation
- Microwave Radio & VSAT
- Military & Space
- Telecom Infrastructure
- Fiber Optics

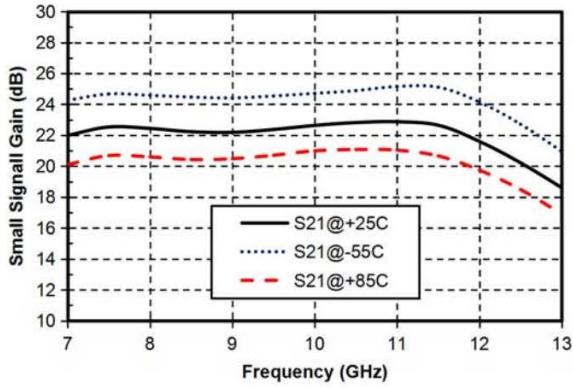
### Electrical Specifications

TA = +25°C, Vd = +8V, \*Ids=550mA

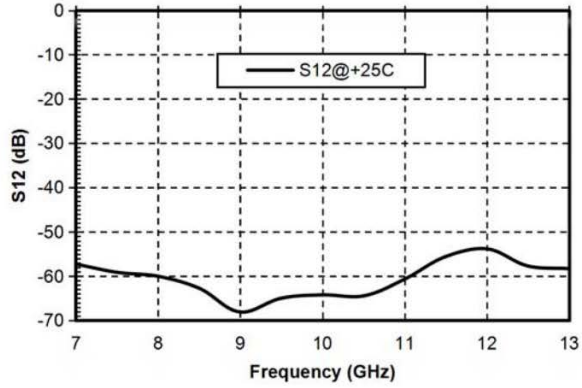
Parameters	Min.	Typ.	Max.	Units
Frequency	8-12			GHz
Small Signal Gain	-	22	-	dB
Gain Flatness	$\pm 0.6$			dB
P-1dB	-	33.5	-	dBm
Psat	-	34	-	dBm
Input Return Loss		20		dB
Output Return Loss		10		dB
Quiescent Current		550		mA
* Adjust Vg (-2V-0V), Recommended Vg -0.75V.				



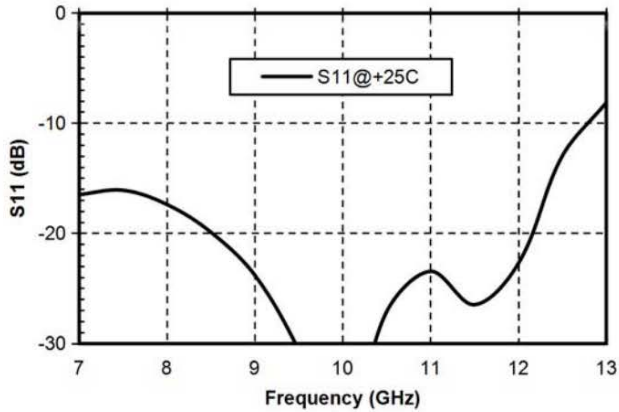
### Gain vs. Frequency



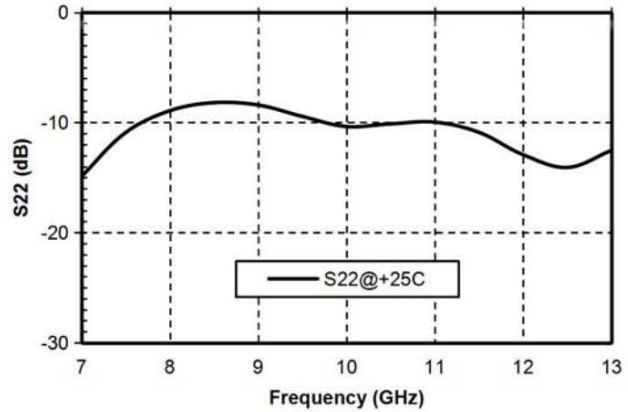
### Isolation vs. Frequency



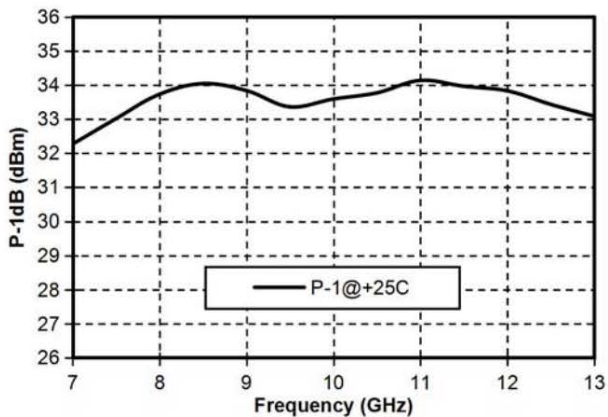
### Input Return Loss vs. Frequency



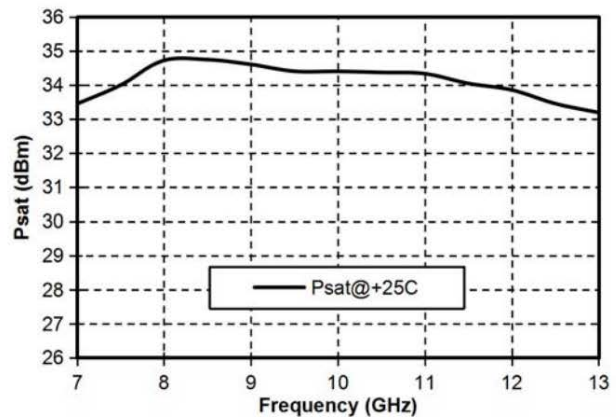
### Output Return Loss vs. Frequency



### P-1dB vs. Frequency

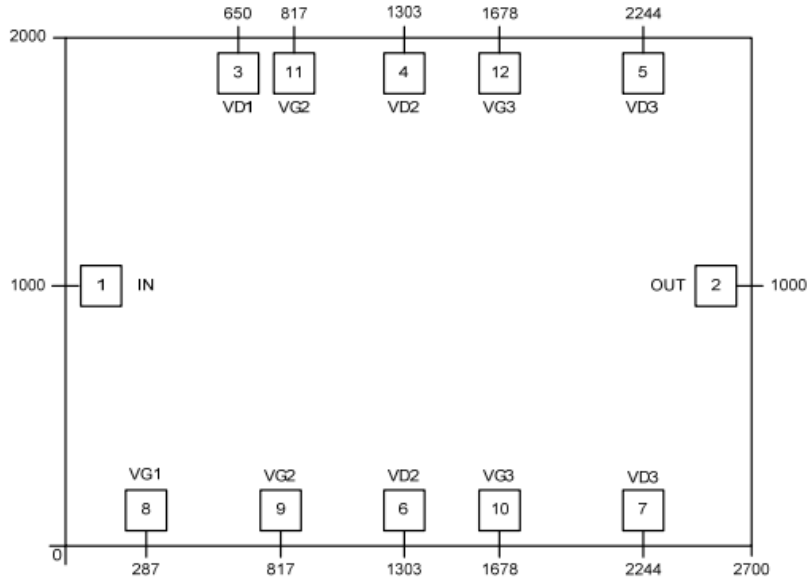


### Psat vs. Frequency





**Outline Drawing:**  
All Dimensions in  $\mu\text{m}$

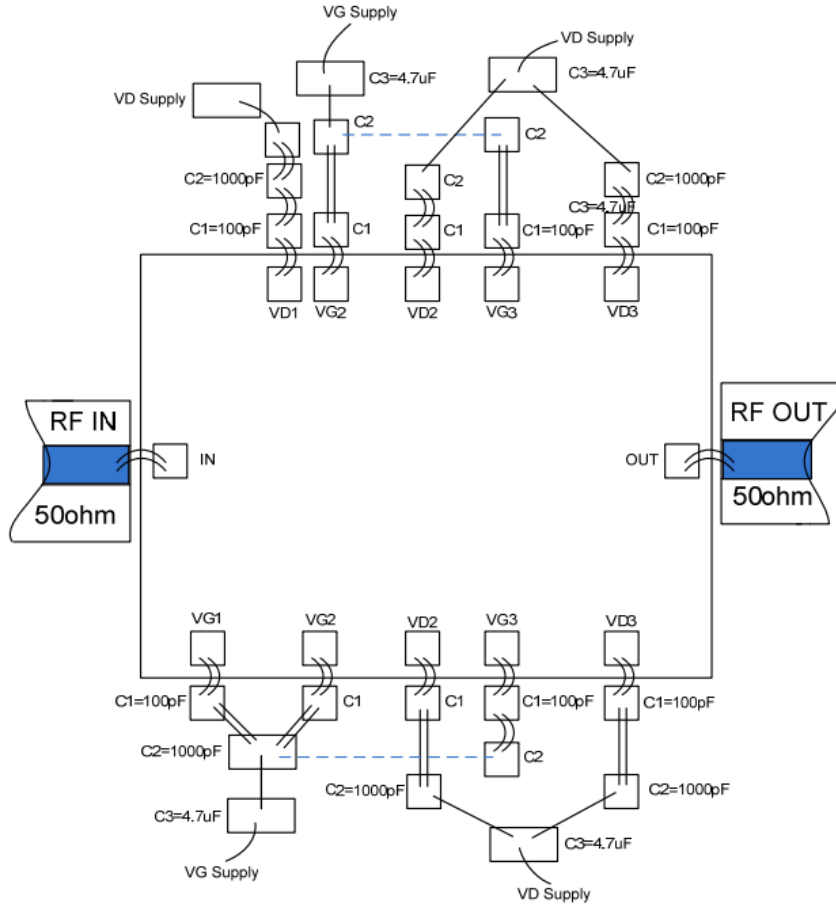


**Pad Description**

Pad	Function	Description
1	RF IN	Signal input terminal; no blocking capacitor required.
2	RF OUT	Signal output terminal; no blocking capacitor required.
3, 4, 5, 6, 7	Vd1, Vd2	Amplifier drain bias; external 100pF, 1000pF, 4.7uF bypass capacitor required.
8, 9, 10, 11, 12	Vg1, Vg2	Amplifier gate bias; external 100pF, 1000pF, 4.7uF bypass capacitor required.
Die bottom	GND	Die bottom must be connected to RF/DC ground.



### Assembly Drawing



**Note:**

- C1 100pF
- C2 1000pF
- C3 4.7uF

**Notes:**

1. Die thickness: 100um
2. Typical bond pad is 100\*100  $\mu\text{m}^2$
3. Bond pad metalization: Gold
4. Backside metalization: Gold
5. Backside of the die (GND)
6. No connection required for unlabeled bond pads

**Maximum Ratings:**

1. Maximum drain voltage: +10V
2. Maximum input power: +25dBm
3. Operating temperature: -55°C to +85°C
4. Storage temperature: -65°C to +150°C